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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Re Application of

Atty. Docket

RENE MONSHOUWER ET AL

NL 000771

Serial No. 09/940,818

Group Art Unit: 287

Filed: AUGUST 28, 2001

Ex.:

Title: METHOD OF MEASURING OVERLAY

Commissioner for Patents
Washington, D.C. 20231

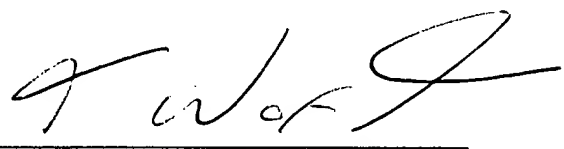
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INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.97

Sir:

Enclosed is a copy of a foreign search report issued in
a related application. The documents cited are "A"
(technical background) only.

Respectfully submitted,

By 
Aaron Waxler, Reg. 48,027
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CERTIFICATE OF MAILING

I hereby certify that this correspondence is being
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